

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): AKASHE et al.

Appln. No.: 09/939,500

Title: METHOD OF DEFLAVORING  
SOY-DERIVED MATERIALS

Group Art  
Unit: 1761

Examiner: Weier, Anthony J.

CERTIFICATE OF MAILING

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner of Patents  
Attention: Assistant Commissioner for Patents  
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Alexandria, VA 22313-1450

Sir:

Pursuant to the provisions of 37 C.F.R. §§ 1.56, 1.97  
and 1.98, a copy of each document listed below and on the  
enclosed Form PTO/SB/08A is submitted herewith.

<u>U.S. Patent No.</u>	<u>Inventor</u>	<u>Issue Date</u>
4,100,024	Adler-Nissen	Jul. 11, 1978
4,205,090	Maubois et al.	May 27, 1980
4,478,854	Adler-Nissen et al.	Oct. 23, 1984
4,497,836	Marquardt et al.	Feb. 5, 1985
4,530,788	Chang	Jul. 23, 1985
4,623,550	Willard	Nov. 18, 1986
4,632,903	Boyce et al.	Dec. 30, 1986
Re.32,725	Howard et al.	Aug. 2, 1988
4,770,891	Willard	Sept. 13, 1988
5,077,062	Ernster	Dec. 31, 1991
5,100,679	Delrue	Mar. 31, 1992
5,160,758	Parks et al.	Nov. 3, 1992
5,433,969	McMindes et al.	Jul. 18, 1995
5,626,899	Payne et al.	May 6, 1997
5,780,439	Mendy et al.	Jul. 14, 1998
5,858,442	Payne et al.	Jan. 12, 1999
6,022,702	Tsumura et al.	Feb. 8, 2000
6,068,865	Lee et al.	May 30, 2000
6,126,973	Tsumura et al.	Oct. 3, 2000
6,136,351	Nauth et al.	Oct. 24, 2000
6,139,901	Blazey et al.	Oct. 31, 2000

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Foreign References

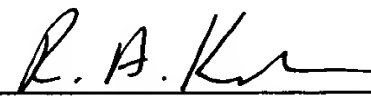
GB 1580051	Graham et al.	Nov. 26, 1980
WO 02/100186	Porter et al.	Dec. 19, 2002

The Commissioner is hereby authorized to charge any fees which may be required in respect to this communication or credit any overpayment to Deposit Account No. 06-1135.

Respectfully submitted,

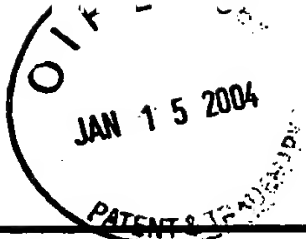
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<b>PTO/SB/08A</b> Substitute for Form PTO-1449  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(use as many sheets as necessary)</i>				Application Number	09/939,500
				Filing Date	August 23, 2001
				First Named Inventor	AKASHE et al.
				Art Unit	1761
				Examiner Name	Weier, Anthony J.
Sheet	1	of	2	Attorney Docket	67200

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup>			
		US-4,100,024	07/11/1978	Adler-Nissen	
		US-4,205,090	05/27/1980	Maubois et al.	
		US-4,478,854	10/23/1984	Adler-Nissen et al.	
		US-4,497,836	02/05/1985	Marquardt et al.	
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		US-4,623,550	11/18/1986	Willard	
		US-4,632,903	12/30/1986	Boyce et al.	
		US-Re.32,725	08/02/1988	Howard et al.	
		US-4,770,891	09/13/1988	Willard	
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		US-5,626,899	05/06/1997	Payne et al.	
		US-5,780,439	07/14/1998	Mendy et al.	
		US-5,858,442	01/12/1999	Payne et al.	
		US-6,022,702	02/08/2000	Tsumura et al.	
		US-6,068,865	05/30/2000	Lee et al.	
		US-6,126,973	10/03/2000	Tsumura et al.	
		US-6,136,351	10/24/2000	Nauth et al.	
		US-6,139,901	10/31/2000	Blazey et al.	
		US-6,221,423	04/24/2001	Cho et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup>			

Examiner Signature		Date Considered	
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kind Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04.

<sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

